# P802.3ck D1.4 120G C2M Miscellaneous discussion

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### Introduction

Slides to help address comments related to the 120G C2M miscellaneous comments.

# Comments 154 Annex 120G EO Method

C/ 120G SC 120G.5.2 P 246 L 23 # 154

Dawe, Piers Nvidia

Comment Type TR Comment Status D

EO method

Of all the options in dawe\_3ck\_01a\_1020, this draft has the most primitive (rectangular eye mask) although it is described as a histogram. It's an inefficient/inaccurate way of measuring a signal and provides weak and uncertain protection against too much jitter. This will get worse if we relax the VEC limits, and is a particular concern for very short host channels (see Mike Dudek's work).

#### SuggestedRemedy

Change from a 4-cornered mask with corners at t = ts+/-0.05, V = +/-Hmin/2 to a 10-cornered mask with corners at t = ts+/-0.05, ts+/-0.07, ts+/-0.1, V = +/-Hmin/2, +/-0.1

(In case it's not clear, Hmin, already specified, is the greater of EH and Eye Amplitude - VEC. There will be discussion about changing those limits from other comments, but this is a simple scalable method that can remain as the EH and VEC limits are revised.)

#### Proposed Response

Response Status W

PROPOSED REJECT.

This comment proposes a technical change to the draft that does not address technical completeness.

The comment does not provide sufficient evidence to support the proposed changes.

Draft 1.4 fully specifies the eye height and vertical eye closure. Supporting presentations for the current methodology show that necessary eye width is enforced by these specifications.

https://www.ieee802.org/3/ck/public/20\_10/healey\_3ck\_01a\_1020.pdf https://www.ieee802.org/3/ck/public/20\_10/healey\_3ck\_02\_1020.pdf

Broad support for this methodology was demonstrated by D1.3 Straw Polls #9 and #12.

https://www.ieee802.org/3/ck/public/20 10/minutes 3ck 1020 final un approved.pdf

#### Straw Poll #9:

I support the EW/ESMW direction of (Chicago rules):

A: Keep ESMW and eye width

B: Replace EH, ESMW, and eye width with an eye mask as proposed in dawe 3ck 01 1020

C: Remove ESMW and eye width and redefine EH and VEC as proposed in healey\_3ck\_01a\_1020

D: Remove ESMW and eye width and leave EH and VEC as is Results: A: 9, B: 10, C: 24, D: 6

#### Straw Poll #12:

I would support replacing ESMW and EW with the following option from healey\_3ck\_02\_1020

A. "Alt. 2" with TBD = 50 mUI

B. "Alt. 1" with TBD1 = 25 mUl and TBD2 = 25 mUl

C. "Alt. 1" with TBD1 = 50 mUI and TBD2 = 20 mUI

D. "Alt. 2" with TBD = 70 mUI

A: 18, B: 8, C: 4, D: 9

# Comment 18 Annex 120G TP4a stressed input test

C/ 120G SC 120G.3.3.2 P 238 L 6 # 18

Comment Type T Comment Status

Comment Status D TP4a SIT

The host only needs to meet either the near-end or far-end parameters. This should be clear in this "shall" statement.

#### SuggestedRemedy

Change "The input shall satisfy the input tolerance with the parameters in Table 120G–7" to The input shall satisfy the input tolerance with either the near-end or the far-end parameters in Table 120G–7"

Proposed Response

Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

This comment proposes a technical change to the draft that does not address technical completeness.

A statement later in the subclause indicates that the host input need only meet one of the two stressors. See page 239 line 38.

However, it would be helpful to point out the same in this normative statement as well to avoid confusion.

Implement the suggested remedy.

#### 120G.3.3.2 Host stressed input test

The host stressed input tolerance is measured using the procedure defined in 120G.3.3.2.1. The input shall satisfy the input tolerance with the parameters in Table 120G-7.

Table 120G-7—Host stressed input parameters

| Parameter                              | Value        |
|--|--------------|
| Applied peak-to-peak sinusoidal jitter | Table 120G-8 |
| Near-end eye height                    | 24 mV        |
| Near-end vertical eye closure          | 7.5 dB       |
| Far-end eye height                     | 24 mV        |
| Far-end vertical eye closure           | 7.5 dB       |

#### Page 239, line 38

The stressed input is calibrated using either the near-end or the far-end method (see 120G.3.2.2.1), based on the value of tx\_eq\_state as requested by the host (see 120G.3.2.2). The eye height and vertical eye closure are set to the target values in Table 120G-7 when measured according to the method in 120G.5.2. Meeting the BER requirement using only one value of tx\_eq\_state, as requested by the host, is sufficient.

## Comment 67 Annex 120G TP4a stressed input test

SC 120G.3.3.2.1 C/ 120G P 239 L 40 Broadcom Inc. Healey, Adam

Comment Type T The stressed input signal calibration procedure states that "random jitter and the pattern generator output levels are adjusted (without exceeding the differential peak-to-peak input voltage tolerance specification as shown in Table 120G-8) to result in the eye height for all three eyes given in Table 120G-7 with the setting of the CTLE that minimizes the vertical eye closure." The term "output levels" is ambiguous. It could be interpreted to be "pattern generator output amplitude" or "individual PAM-4 signal levels". It seems that the latter is intended but the individual PAM-4 signal levels should not be allowed to be adjusted so far

Comment Status D

#### SuggestedRemedy

Replace the sentence with the following text:

that the level separation mismatch ratio ("RLM") is too low.

'The pattern generator output is adjusted so that the height of the smallest eye matches the value in Table 120G-7, and the height of all three eyes agree to the largest extent possible, for the CTLE setting that minimizes vertical eye closure. The differential peak-topeak input voltage tolerance given in Table 120G-8 is not exceeded. Individual PAM-4 signal levels may be adjusted to improve the agreement of the three eye heights but the level separation mismatch ratio (RLM) is at least 0.95. RLM is defined in 120D.3.1.2 and is calculated using VM0, VM1, VM2, and VM3 as defined in 120G.5.2 in place of V0, V1, V2, and V3 respectively. Random jitter amplitude may also be adjusted to acheive the eye height targets.

A similar change is suggested for 120G.3.4.1.1 (page 242, line 17).

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Implement the suggested remedy in 120G.3.3.2.1 and a similar change in 12G.3.4.1.1 with editorial license.

#### 120G.3.3.2.1, Page 239, line 40

Random jitter and the pattern generator output levels are adjusted (without exceeding the differential peakto-peak input voltage tolerance specification as shown in Table 120G-6) to result in the eye height for all three eyes given in Table 120G-7 with the setting of the CTLE that minimizes the vertical eye closure. Preemphasis capability is likely to be required in the pattern generator to meet this requirement.

#### 120G.3.4.1.1, Page 242, line 17

For the high-loss case, frequency-dependent attenuation is added such that the loss at 26.56 GHz from the output of the pattern generator to TP1a is 18.2 dB. The 18.2 dB loss represents 16 dB channel loss with an additional allowance for host transmitter package loss. Eye height and VEC are then measured at TP1a as described in 120G.5.2. Random litter and the pattern generator output levels are adjusted (without exceeding the differential peak-to-peak input voltage tolerance specification as shown in Figure 120G-9) to result in the eye height for all three eyes given in Table 120G-10 using the reference receiver with the setting that minimizes the vertical eye closure. The CTLE setting, gDC+gDC2, has to be less than or equal to -13 dB.

TP4a SIT levels

### Comments 125, 38, 34, 79 Annex 120G TP1/TP4 ERL

Cl 120G SC 120G.3.4 P240 L 17 # 38

Brown, Matt Huawei

Comment Type T Comment Status D TP1 ERL

In table 120G-9, the specified value for module input ERL (min) is TBD.

SuggestedRemedy Provide a value.

Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.
Resolve using the response to comment #125.

C/ 120G SC 120G.3.2 P 234 L 17 # 34

Brown, Matt Huawei

Comment Type T Comment Status D TP4 ERL

In Table 120G-3, the specified value for ERL at module output (TP4) is TBD.

SuggestedRemedy

Provide a value and update PICS.

Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.
Resolve using the response to comment #125.

Note: Should take into consideration the closed responses to comments for MTF and CA ERL.

**Proposals** 

Module output ERL: 9 dB (125), 8.5 dB (79)

Module input ERL: 8.5 dB (125)

Need to pick a value for module input and module output.

CI 120G SC 120G.3.2 P234 L17 # 125

Ran, Adee Intel

Comment Type TR Comment Status D

Comment Status D TP4 ERL

(addressing TBD)

Module output ERL (min) is TBD

Since it is measured at TP4 the module ERL will be no better than that of a mated test fixture. In another comment I am suggesting setting the minimum ERL of a MTF to 10.3 dB to enable measurement of the internal host circuitry. Based on this proposal, the ERL of a module cannot exceed 10.3 dB.

The proposed value allows 1.3 dB difference for Tx and 1.8 dB for RX for module implementation.

Similarly in 120G.3.4 for module input ERL at TP1.

SuggestedRemedy

Change TBD to 9 dB for Tx ERL and 8.5 dB for Rx ERL.

Proposed Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Two comments propose values for module output ERL (min) as follows:

#79: 8.5 dB #125: 9 dB

Select a value and use this for both module output (120G.3.2) and module input (120G.3.4).

L17

P 234

For task force discussion.

SC 120G.3.2

Ghiasi, Ali Ghiasi Quantum/Inphi

Comment Type TR Comment Status D TP4 ERL

ERL is TBD

C/ 120G

SuggestedRemedy

Replace TBD with 8.5 dB and see ghiasi 3ck 01 0121

Proposed Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Resolve using the response to comment #125.